

National Institute of Standards & Technology

Certificate of Analysis

Standard Reference Material® 3150

Silicon (Si) Standard Solution

Lot No. 130912

This Standard Reference Material (SRM) is intended for use as a primary calibration standard for the quantitative determination of silicon. A unit of SRM 3150 consists of 50 mL of solution prepared gravimetrically to contain a known mass fraction of silicon in a high-density polyethylene bottle sealed in an aluminized bag. The solution is prepared gravimetrically from sodium metasilicate nonahydrate to contain a known mass fraction of silicon in water.

Certified Value of Silicon:

 $9.901 \text{ mg/g} \pm 0.023 \text{ mg/g}$

The certified value is based upon inductively coupled plasma optical emission spectrometry (ICP-OES) calibrated using four primary standards independently prepared from silicon metal assayed by NIST.

The uncertainty in the certified value is calculated as

 $U = ku_c$

where k = 2.021 is the coverage factor for a 95 % confidence interval and 40 effective degrees of freedom. The quantity u_c is the combined standard uncertainty calculated according to the ISO/JCGM and NIST Guides [1]. The value of u_c is intended to represent, at the level of one standard deviation, the combined effect of uncertainty components associated with the ICP-OES determination and stability of the silicon mass fraction. No correction has been applied for transpiration that will occur after the SRM bottle unit has been removed from the sealed bag. See "Instructions for Handling, Storage, and Use" for more information regarding transpiration.

Expiration of Certification: The certification of **SRM 3150 Lot No. 130912** is valid, within the measurement uncertainty specified, until **30 September 2021**, provided the SRM is handled and stored in accordance with instructions given in this certificate (see "Instructions for Handling, Storage, and Use"). This certification is nullified if the SRM is damaged, contaminated, or modified.

Maintenance of Certification: NIST will monitor this SRM over the period of its certification. If substantive technical changes occur that affect the certification before the expiration of certification, NIST will notify the purchaser. Registration (see attached sheet or register online) will facilitate notification.

Coordination of the technical measurements leading to the certification of SRM 3150 was provided by M.R. Winchester and J.L. Molloy of the NIST Chemical Sciences Division.

This SRM was prepared by T.A. Butler of the NIST Chemical Sciences Division. The ICP-OES analysis was performed by T.A. Butler and J.L. Molloy. Primary standards for ICP-OES calibration were prepared by T.A. Butler.

Statistical consultation was provided by A.M. Possolo, of the NIST Statistical Engineering Division.

Support aspects involved in the issuance of this SRM were coordinated through the NIST Office of Reference Materials.

Carlos A. Gonzalez, Chief Chemical Sciences Division

Gaithersburg, MD 20899 Certificate Issue Date: 21 July 2015 Robert L. Watters, Jr., Director Office of Reference Materials

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METROLOGICAL TRACEABILITY

Metrological traceability of measurement results to a given reference must be established through an unbroken chain of calibrations and/or comparisons, each having stated uncertainties [2], using measurement standards that are appropriate for the physical or chemical property being measured. Comparisons may include validation measurements using various spectroscopic or classical methods of analysis. Gravimetric or volumetric dilution is also a method of comparison, where the mass or volume of a solution before and after dilution is measured.

For this SRM, the measurand is the total concentration of silicon, expressed as mass fraction and the certified value is metrologically traceable to the SI unit of mass. This SRM can be used to establish traceability of the results of silicon measurements to NIST measurement results and standards. One approach is to calibrate analytical instruments or procedures for the determination of silicon using standards whose values are traceable to the certified value of silicon in this SRM. When the traceable values of such standards are assigned using this SRM for calibration, the uncertainties assigned to those values must include the uncertainty of the certified value of this SRM, appropriately combined with the uncertainties of all calibration measurements.

INSTRUCTIONS FOR HANDLING, STORAGE, AND USE

This SRM can be used to prepare working standard solutions in the range of 10 mg/kg to 100 mg/kg, from which more dilute standards can be prepared. The user should establish internal laboratory procedures that specify a maximum shelf-life for a working standard solution. Two procedures for the preparation of working standard solutions follow.

Preparation of Working Standard Solutions by Mass: Each working standard solution should be prepared by transferring an aliquot of the SRM into an empty, dry, preweighed polyethylene bottle and then reweighing the bottle. An appropriate dilute acid (or for some applications water of appropriate purity) must be added by mass to bring the solution to the desired dilution. The dilution need not be exact since the mass of the empty bottle, mass of the bottle plus SRM aliquot, and the final diluted mass of the solution will permit calculation of the exact mass fraction (i.e., mass of silicon per mass of solution) of the working standard solution. Dilutions prepared gravimetrically as described will need no correction for temperature and no further correction for true mass fraction in vacuum.

Preparation of Working Standard Solutions by Volume: Volumetric dilutions are NOT recommended due to uncertainties in volume calibrations and variations in density. However, for user convenience, a procedure for volumetric preparation that will minimize the major sources of error is given. Each working standard solution should be prepared by transferring an aliquot of the SRM to an empty, dry polyethylene bottle and then weighing the bottle. The solution must now be transferred to a Class A volumetric flask and the polyethylene bottle reweighed to determine the exact mass of SRM solution transferred. The solution in the flask is then diluted to 99 % + volume using an appropriate dilute acid (or for some applications water of appropriate purity), mixed thoroughly, and the remaining few drops needed to dilute to exact volume carefully added. The concentration (in milligrams per milliliter) of the resulting working standard solution can then be calculated by multiplying the mass (in grams) of the SRM solution amount by the SRM certified value (in milligrams per gram) and dividing the numerical product by the calibrated volume (in milliliters) of the flask used for dilution. Thus, no correction for density is needed. Although the concentration of the resulting working standard solution may be an uneven fraction of the original SRM concentration, it will be known as accurately as a volumetric dilution permits.

Transpiration: While stored in the aluminized bag, transpiration of this SRM is negligible. After the SRM has been removed from the aluminized bag, transpiration will occur at a solution mass loss rate of approximately 0.2 % relative per year, resulting in a gradual increase in the element mass fraction. It is the responsibility of the user to account for this effect. The recommended way to reduce the effects of transpiration is to deliver all of the SRM as aliquots weighed into appropriate vessels as soon as the SRM is removed from the aluminized bag. The aliquots may be stored and can be diluted to known mass or volume later. Storage of a partially used SRM bottle is **NOT** recommended; however, if such storage is necessary, the cap should be tightly sealed and the SRM bottle kept in an airtight container to slow the rate of transpiration. When the bottle is weighed both before and after being placed in storage, the mass difference observed will be a measure of transpiration mass loss. The user should set a maximum shelf-life *for a partially used SRM bottle* commensurate with accuracy requirements.

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REFERENCES

- [1] JCGM 100:2008; Evaluation of Measurement Data Guide to the Expression of Uncertainty in Measurement (GUM 1995 with Minor Corrections); Joint Committee for Guides in Metrology (2008); available at http://www.bipm.org/utils/common/documents/jcgm/JCGM_100_2008_E.pdf (accessed July 2015); see also Taylor, B.N.; Kuyatt, C.E.; Guidelines for Evaluating and Expressing the Uncertainty of NIST Measurement Results; NIST Technical Note 1297; U.S. Government Printing Office: Washington, DC (1994); available at http://www.nist.gov/pml/pubs/tn1297/index.cfm (accessed July 2015).
- [2] JCGM 200:2012; International Vocabulary of Metrology Basic and General Concepts and Associated Terms, 3rd ed.; JCGM (2012); available at http://www.bipm.org/utils/common/documents/jcgm/JCGM_200_2012 (accessed July 2015).

Users of this SRM should ensure that the Certificate of Analysis in their possession is current. This can be accomplished by contacting the SRM Program: telephone (301) 975-2200; fax (301) 948-3730; e-mail srminfo@nist.gov; or via the Internet http://www.nist.gov/srm.

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